Dual Frequency Crystal Oscillator (XO) 100 kHz to 250 MHz

Features

- Supports any frequency from 100 kHz to 250 MHz
- Two selectable output frequencies
- Low-jitter operation
- 2 to 4 week lead times
- Total stability includes 10-year aging
- Comprehensive production test coverage includes crystal ESR and DLD
- On-chip LDO regulator for power supply noise filtering
- 3.3, 2.5, or 1.8 V operation
- Differential (LVPECL, LVDS, HCSL) or CMOS output options
- Optional integrated 1:2 CMOS fanout buffer
- Runt suppression on OE and power on
- Industry standard 5x7, 3.2x5, and 2.5x3.2 mm packages
- Pb-free, RoHS compliant
- –40 to 85 °C operation

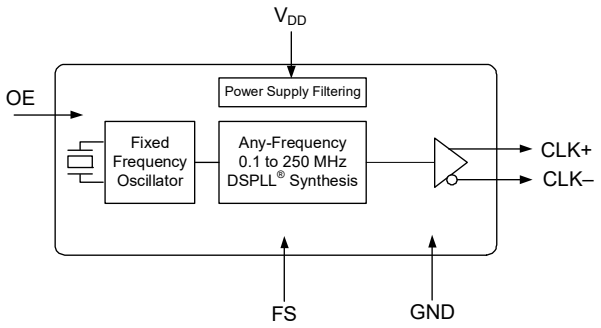
Applications

- SONET/SDH/OTN
- Gigabit Ethernet
- Fibre Channel/SAS/SATA
- PCI Express
- Broadcast video
- Switches/routers
- Telecom
- FPGA/ASIC clock generation

Description

The Si512/513 dual frequency XO utilizes Skyworks Solutions' advanced PLL technology to provide any frequency from 100 kHz to 250 MHz. Unlike a traditional XO where a different crystal is required for each output frequency, the Si512/513 uses one fixed crystal and Skyworks Solutions' proprietary any-frequency synthesizer to generate any frequency across this range. This IC-based approach allows the crystal resonator to provide enhanced reliability, improved mechanical robustness, and excellent stability. In addition, this solution provides superior supply noise rejection, simplifying low jitter clock generation in noisy environments. The Si512/513 is factory-configurable for a wide variety of user specifications, including frequency, supply voltage, output format, output enable polarity, and stability. Specific configurations are factory-programmed at time of shipment, eliminating long lead times and non-recurring engineering charges associated with custom frequency oscillators.

Functional Block Diagram



2.5x3.2mm

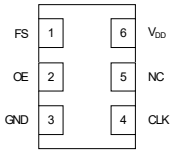
5x7mm and 3.2x5mm

Ordering Information:

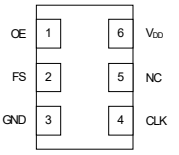
See page 13.

Pin Assignments:

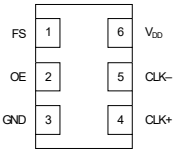
See page 12.



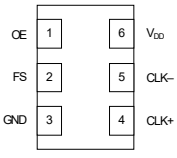
Si512 CMOS Dual XO



Si513 CMOS Dual XO



Si512 LVDS/LVPECL/HCSL/CMOS Dual XO



Si513 LVDS/LVPECL/HCSL/CMOS Dual XO

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1. Electrical Specifications

Table 1. Operating Specifications

V_{DD} = 1.8 V ±5%, 2.5 or 3.3 V ±10%, T_A = –40 to +85 °C

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Supply Voltage	V_{DD}	3.3 V option	2.97	3.3	3.63	V
		2.5 V option	2.25	2.5	2.75	V
		1.8 V option	1.71	1.8	1.89	V
Supply Current	I_{DD}	CMOS, 100 MHz, single-ended	—	21	26	mA
		LVDS (output enabled)	—	19	23	mA
		LVPECL (output enabled)	—	39	43	mA
		HCSL (output enabled)	—	41	44	mA
		Tristate (output disabled)	—	—	18	mA
FS, OE "1" Setting	V_{IH}	See Note	0.80 x V_{DD}	—	—	V
FS, OE "0" Setting	V_{IL}	See Note	—	—	0.20 x V_{DD}	V
FS, OE Internal Pull-Up/Pull-Down Resistor*	R_I		—	45	—	kΩ
Operating Temperature	T_A		–40	—	85	°C

Note: Active high and active low polarity OE options available. Active high uses internal pull-up. Active low uses internal pull-down. See ordering information on page 12.

Table 2. Output Clock Frequency Characteristics

V_{DD} = 1.8 V ±5%, 2.5 or 3.3 V ±10%, T_A = –40 to +85 °C

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Nominal Frequency	F_O	CMOS, Dual CMOS	0.1	—	212.5	MHz
	F_O	LVDS/LVPECL/HCSL	0.1	—	250	MHz
Total Stability*		Frequency Stability Grade C	–30		+30	ppm
		Frequency Stability Grade B	–50		+50	ppm
		Frequency Stability Grade A	–100		+100	ppm
Temperature Stability		Frequency Stability Grade C	–20		+20	ppm
		Frequency Stability Grade B	–25		+25	ppm
		Frequency Stability Grade A	–50		+50	ppm
Startup Time	T_{SU}	Minimum V_{DD} to output frequency (F_O) within specification	—	—	10	ms
Disable Time	T_D	$F_O \geq 10$ MHz	—	—	5	µs
		$F_O < 10$ MHz	—	—	40	µs
Enable Time	T_E	$F_O \geq 10$ MHz	—	—	20	µs
		$F_O < 10$ MHz	—	—	60	µs
Settling Time after FS Change	t_{FRQ}		—	—	10	ms

***Note:** Total stability includes initial accuracy, operating temperature, supply voltage change, load change, shock and vibration (not under operation), and 10 years aging at 40 °C.

Table 3. Output Clock Levels and Symmetry

V_{DD} = 1.8 V ±5%, 2.5 or 3.3 V ±10%, T_A = –40 to +85 °C

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
CMOS Output Logic High	V_{OH}		0.85 x V_{DD}	—	—	V
CMOS Output Logic Low	V_{OL}		—	—	0.15 x V_{DD}	V
CMOS Output Logic High Drive	I_{OH}	3.3 V	–8	—	—	mA
		2.5 V	–6	—	—	mA
		1.8 V	–4	—	—	mA
CMOS Output Logic Low Drive	I_{OL}	3.3 V	8	—	—	mA
		2.5 V	6	—	—	mA
		1.8 V	4	—	—	mA
CMOS Output Rise/Fall Time (20 to 80% V_{DD})	T_R/T_F	0.1 to 125 MHz, C_L = 15 pF	—	0.8	1.2	ns
		0.1 to 212.5 MHz, C_L = no load	—	0.6	0.9	ns
LVPECL/HCSL Output Rise/Fall Time (20 to 80% V_{DD})	T_R/T_F		—	—	565	ps
LVDS Output Rise/Fall Time (20 to 80% V_{DD})	T_R/T_F		—	—	800	ps
LVPECL Output Common Mode	V_{OC}	50 Ω to V_{DD} – 2 V, single-ended	—	V_{DD} – 1.4 V	—	V
LVPECL Output Swing	V_O	50 Ω to V_{DD} – 2 V, single-ended	0.55	0.8	0.90	V_{PPSE}
LVDS Output Common Mode	V_{OC}	100 Ω line-line, V_{DD} = 3.3/2.5 V	1.13	1.23	1.33	V
		100 Ω line-line, V_{DD} = 1.8 V	0.83	0.92	1.00	V
LVDS Output Swing	V_O	Single-ended, 100 Ω differential termination	0.25	0.35	0.45	V_{PPSE}
HCSL Output Common Mode	V_{OC}	50 Ω to ground	0.35	0.38	0.42	V
HCSL Output Swing	V_O	Single-ended	0.58	0.73	0.85	V_{PPSE}
Duty Cycle	DC	All Output Formats	48	50	52	%

Table 4. Output Clock Jitter and Phase Noise (LVPECL)

V_{DD} = 2.5 or 3.3 V ±10%, T_A = –40 to +85 °C; Output Format = LVPECL

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Period Jitter (RMS)	JPRMS	10k samples[1]	—	—	1.3	ps
Period Jitter (Pk-Pk)	JPPKPK	10k samples[1]	—	—	11	ps
Phase Jitter (RMS)	φJ	1.875 MHz to 20 MHz integration bandwidth[2] (brickwall)	—	0.31	0.5	ps
		12 kHz to 20 MHz integration bandwidth (brickwall)[2]	—	0.8	1.0	ps
Phase Noise, 156.25 MHz	φN	100 Hz	—	–86	—	dBc/Hz
		1 kHz	—	–109	—	dBc/Hz
		10 kHz	—	–116	—	dBc/Hz
		100 kHz	—	–123	—	dBc/Hz
		1 MHz	—	–136	—	dBc/Hz
Additive RMS Jitter Due to External Power Supply Noise[3]	JPSR	10 kHz sinusoidal noise	—	3.0	—	ps
		100 kHz sinusoidal noise	—	3.5	—	ps
		500 kHz sinusoidal noise	—	3.5	—	ps
		1 MHz sinusoidal noise	—	3.5	—	ps
Spurious	SPR	LVPECL output, 156.25 MHz, offset > 10 kHz	—	–75	—	dBc

Notes:
1. Applies to output frequencies: 74.17582, 74.25, 75, 77.76, 100, 106.25, 125, 148.35165, 148.5, 150, 155.52, 156.25, 212.5, 250 MHz.
2. Applies to output frequencies: 100, 106.25, 125, 148.35165, 148.5, 150, 155.52, 156.25, 212.5 and 250 MHz.
3. 156.25 MHz. Increase in jitter on output clock due to sinewave noise added to VDD (2.5/3.3 V = 100 mVPP).

Table 5. Output Clock Jitter and Phase Noise (LVDS)

V_{DD} = 1.8 V ±5%, 2.5 or 3.3 V ±10%, T_A = –40 to +85 °C; Output Format = LVDS

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Period Jitter (RMS)	JPRMS	10k samples[1]	—	—	2.1	ps
Period Jitter (Pk-Pk)	JPPKPK	10k samples[1]	—	—	18	ps
Phase Jitter (RMS)	φJ	1.875 MHz to 20 MHz integration bandwidth[2] (brickwall)	—	0.25	0.55	ps
		12 kHz to 20 MHz integration bandwidth[2] (brickwall)	—	0.8	1.0	ps
Phase Noise, 156.25 MHz	φN	100 Hz	—	–86	—	dBc/Hz
		1 kHz	—	–109	—	dBc/Hz
		10 kHz	—	–116	—	dBc/Hz
		100 kHz	—	–123	—	dBc/Hz
		1 MHz	—	–136	—	dBc/Hz
Spurious	SPR	LVPECL output, 156.25 MHz, offset>10 kHz	—	–75	—	dBc

Notes:
1. Applies to output frequencies: 74.17582, 74.25, 75, 77.76, 100, 106.25, 125, 148.35165, 148.5, 150, 155.52, 156.25, 212.5, 250 MHz.
2. Applies to output frequencies: 100, 106.25, 125, 148.35165, 148.5, 150, 155.52, 156.25, 212.5 and 250 MHz.

Table 6. Output Clock Jitter and Phase Noise (HCSL)

V_{DD} = 1.8 V ±5%, 2.5 or 3.3 V ±10%, T_A = –40 to +85 °C; Output Format = HCSL

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Period Jitter (RMS)	JPRMS	10k samples*	—	—	1.2	ps
Period Jitter (Pk-Pk)	JPPKPK	10k samples*	—	—	11	ps
Phase Jitter (RMS)	φJ	1.875 MHz to 20 MHz integration bandwidth* (brickwall)	—	0.25	0.30	ps
		12 kHz to 20 MHz integration bandwidth* (brickwall)	—	0.8	1.0	ps
Phase Noise, 156.25 MHz	φN	100 Hz	—	–90	—	dBc/Hz
		1 kHz	—	–112	—	dBc/Hz
		10 kHz	—	–120	—	dBc/Hz
		100 kHz	—	–127	—	dBc/Hz
		1 MHz	—	–140	—	dBc/Hz
Spurious	SPR	LVPECL output, 156.25 MHz, offset>10 kHz	—	–75	—	dBc

***Note:** Applies to an output frequency of 100 MHz.

Table 7. Output Clock Jitter and Phase Noise (CMOS, Dual CMOS)

V_{DD} = 1.8 V ±5%, 2.5 or 3.3 V ±10%, T_A = –40 to +85 °C; Output Format = CMOS, Dual CMOS

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Phase Jitter (RMS)	φJ	1.875 MHz to 20 MHz integration bandwidth[2] (brickwall)	—	0.25	0.35	ps
		12 kHz to 20 MHz integration bandwidth[2] (brickwall)	—	0.8	1.0	ps
Phase Noise, 156.25 MHz	φN	100 Hz	—	–86	—	dBc/Hz
		1 kHz	—	–108	—	dBc/Hz
		10 kHz	—	–115	—	dBc/Hz
		100 kHz	—	–123	—	dBc/Hz
		1 MHz	—	–136	—	dBc/Hz
Spurious	SPR	LVPECL output, 156.25 MHz, offset>10 kHz	—	–75	—	dBc

Notes:
1. Applies to output frequencies: 74.17582, 74.25, 75, 77.76, 100, 106.25, 125, 148.35165, 148.5, 150, 155.52, 156.25, 212.5 MHz.
2. Applies to output frequencies: 100, 106.25, 125, 148.35165, 148.5, 150, 155.52, 156.25, 212.5 MHz.

Table 8. Environmental Compliance and Package Information

Parameter	Conditions/Test Method
Mechanical Shock	MIL-STD-883, Method 2002
Mechanical Vibration	MIL-STD-883, Method 2007
Solderability	MIL-STD-883, Method 2003
Gross and Fine Leak	MIL-STD-883, Method 1014
Resistance to Solder Heat	MIL-STD-883, Method 2036
Contact Pads	Gold over Nickel

Table 9. Thermal Characteristics

Parameter	Symbol	Test Condition	Value	Unit
CLCC, Thermal Resistance Junction to Ambient	θ_{JA}	Still air	110	°C/W
2.5x3.2mm, Thermal Resistance Junction to Ambient	θ_{JA}	Still air	164	°C/W

Table 10. Absolute Maximum Ratings[1]

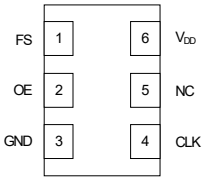
Parameter	Symbol	Rating	Units
Maximum Operating Temperature	T_{AMAX}	85	°C
Storage Temperature	T_S	–55 to +125	°C
Supply Voltage	V_{DD}	–0.5 to +3.8	V
Input Voltage (any input pin)	V_I	–0.5 to V_{DD} + 0.3	V
ESD Sensitivity (HBM, per JESD22-A114)	HBM	2	kV
Soldering Temperature (Pb-free profile)[2]	T_{PEAK}	260	°C
Soldering Temperature Time at T_{PEAK} (Pb-free profile)[2]	T_P	20–40	sec

Notes:
1. Stresses beyond those listed in this table may cause permanent damage to the device. Functional operation or specification compliance is not implied at these conditions. Exposure to maximum rating conditions for extended periods may affect device reliability.
2. The device is compliant with JEDEC J-STD-020E.

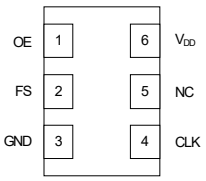
2. Solder Reflow and Rework Requirements for 2.5x3.2 mm Packages

Reflow of Skyworks Solutions' components should be done in a manner consistent with the IPC/JEDEC J-STD-20E standard. The temperature of the package is not to exceed the classification Temperature provided in the standard. The part should not be within -5°C of the classification or peak reflow temperature (T_{PEAK}) for longer than 30 seconds. Key to maintaining the integrity of the component is providing uniform heating and cooling of the part during reflow and rework. Uniform heating is achieved through having a preheat soak and controlling the temperature ramps in the process. J-STD-20E provides minimum and maximum temperatures and times for the preheat/Soak step that need to be followed, even for rework. The entire assembly area should be heated during rework. Hot air should be flowed from both the bottom of the board and the top of the component. Heating from the top only will cause un-even heating of component and can lead to part integrity issues. Temperature Ramp-up rate are not to exceed 3°C/second. Temperature ramp-down rates from peak to final temperature are not to exceed 6°C/second. Time from 25°C to peak temperature is not to exceed 8 min for Pb-free solders.

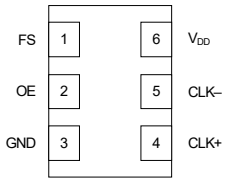
3. Pin Descriptions



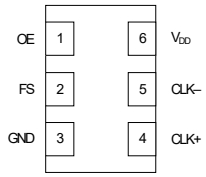
Si512 CMOS



Si513 CMOS



Si512 LVDS/LVPECL/ HCSL/ Dual CMOS*



Si513 LVDS/LVPECL/ HCSL/Dual CMOS*

***Note:** Supports integrated 1:2 CMOS buffer. See section 2.1 “3.1. Dual CMOS Buffer” and section 3 “4. Ordering Information”.

Table 11. Si512 Pin Descriptions (CMOS, OE Pin 2)

Pin	Name	CMOS Function
1	FS	Frequency Selected. 0 = First frequency selected. 1 = Second frequency selected.
2	OE	Output Enable. Internal pull-up for OE active high. Pull-down for OE active low. See ordering information.
3	GND	Electrical and Case Ground.
4	CLK	Clock Output.
5	NC	No connect. Make no external connection to this pin.
6	V_{DD}	Power Supply Voltage.

Table 12. Si513 Pin Descriptions (CMOS, OE Pin 1)

Pin	Name	CMOS Function
1	OE	Output Enable. Internal pull-up for OE active high. Pull-down for OE active low. See ordering information.
2	FS	Frequency Selected. 0 = First frequency selected. 1 = Second frequency selected.
3	GND	Electrical and Case Ground.
4	CLK	Clock Output.
5	NC	No connect. Make no external connection to this pin.
6	V_{DD}	Power Supply Voltage.

Table 13. Si512 Pin Descriptions (OE Pin 2)

Pin	Name	LVPECL/LVDS/HCSL/Dual CMOS Function
1	FS	Frequency Selected. 0 = First frequency selected. 1 = Second frequency selected.
2	OE	Output Enable. Internal pull-up for OE active high. Pull-down for OE active low. See ordering information.
3	GND	Electrical and Case Ground.
4	CLK+	Clock Output.
5	CLK–	Complementary Clock Output.
6	V_{DD}	Power Supply Voltage.

Table 14. Si513 Pin Descriptions (OE Pin 1)

Pin	Name	LVPECL/LVDS/HCSL/Dual CMOS Function
1	OE	Output Enable. Internal pull-up for OE active high. Pull-down for OE active low. See ordering information.
2	FS	Frequency Selected. 0 = First frequency selected. 1 = Second frequency selected.
3	GND	Electrical and Case Ground.
4	CLK+	Clock Output.
5	CLK–	Complementary Clock Output.
6	V_{DD}	Power Supply Voltage.

3.1. Dual CMOS Buffer

Dual CMOS output format ordering options support either complementary or in-phase output signals. This feature enables replacement of multiple XOs with a single Si512/13 device.

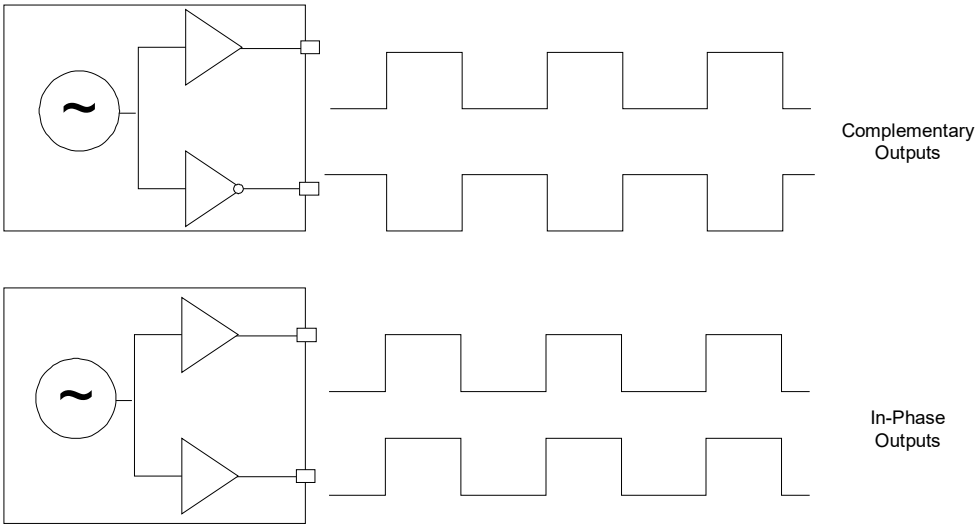


Figure 1. Integrated 1:2 CMOS Buffer Supports Complementary or In-Phase Outputs

4. Ordering Information

The Si512/513 supports a wide variety of options including frequency, stability, output format, and V_{DD}. Specific device configurations are programmed into the Si512/513 at time of shipment. Configurations can be specified using the Part Number Configuration chart below. Skyworks Solutions provides a web browser-based part number configuration utility to simplify this process. Refer to www.skyworksinc.com/products/timing-oscillators and click "Customize" in the product table. The Si512/513 XO series is supplied in industry-standard, RoHS compliant, lead-free, 2.5 x 3.2 mm, 3.2 x 5.0 mm, and 5 x 7 mm packages. Tape and reel packaging is an ordering option.

Series	Output Format	Package
514	LVPECL, LVDS, HCSL, CMOS, Dual CMOS	6-pin

A = Revision: A
G = Temp Range: -40°C to 85°C
R = Tape & Reel; Blank = Coil Tape

514 X X X XXXXXX X AGR

1st Option Code: Output Format

	VDD	Output Format
A	3.3V	LVPECL
B	3.3V	LVDS
C	3.3V	CMOS
D	3.3V	HCSL
E	2.5V	LVPECL
F	2.5V	LVDS
G	2.5V	CMOS
H	2.5V	HCSL
J	1.8V	LVDS
K	1.8V	CMOS
L	1.8V	HCSL
M	3.3V	Dual CMOS (In-phase)
N	3.3V	Dual CMOS (Complementary)
P	2.5V	Dual CMOS (In-phase)
Q	2.5V	Dual CMOS (Complementary)
R	1.8V	Dual CMOS (In-phase)
S	1.8V	Dual CMOS (Complementary)

3rd Option Code: Frequency Grade

	CMOS (MHz)	LVPECL, LVDS, HCSL (MHz)
A	0.1 to 212.5	0.1 to 250
B	0.1 to 170	0.1 to 170
C	0.1 to 125	0.1 to 125

Package Option

	Dimensions
A	5 x 7 mm
B	3.2 x 5 mm
C	2.5 x 3.2 mm

2nd Option Code: Frequency Stability

	Total	Temperature
A	±100ppm	±50ppm
B	±50ppm	±25ppm
C	±30ppm	±20ppm

6-digit Frequency and Default I²C Address Code

Code	Description
xxxxxx	The Si514 supports a user-defined start-up frequency which must be in the same range as specified by the Frequency Grade code. A user-defined, 7-bit I²C address is supported. Each unique start-up frequency/I²C address combination is assigned a 6-digit code by: (see ** below).

** www.skyworksinc.com/en/application-pages/timing-lookup-customize

Figure 2. Part Number Convention

Example part number: 512PCA000104BAGR:

The series prefix, 512, indicates the device is a Dual CMOS XO with the OE function on pin 2. The output format code P specifies the outputs are dual in-phase CMOS with a 2.5 V supply. The frequency stability code C indicates a total stability of ± 30 ppm. The frequency select and output enable code A specifies that the two frequencies are listed in ascending order, with the output frequency f0 (the lower frequency) selected when FS=0, and f1 (the higher frequency) selected when FS = 1. The device's output enable polarity is active High.

The six-digit code is 000104. Refer to the part number lookup at www.skyworksinc.com/products/timing-oscillators. f0 is 155.52 MHz (the lower frequency) and f1 is 156.25 MHz (the higher frequency). The package code B refers to the 3.2 x 5 mm footprint with six pins. The last A refers to the product revision, G indicates the temperature range (–40 to +85°C), and R means the device ships in tape and reel format.

Note: CMOS and Dual CMOS maximum frequency is 212.5 MHz.

5. Package Outline Diagram, 5 x 7 mm, 6-pin

Figure 3 illustrates the package details for the 5 x 7 mm Si512/513. Table 15 lists the values for the dimensions shown in the illustration.

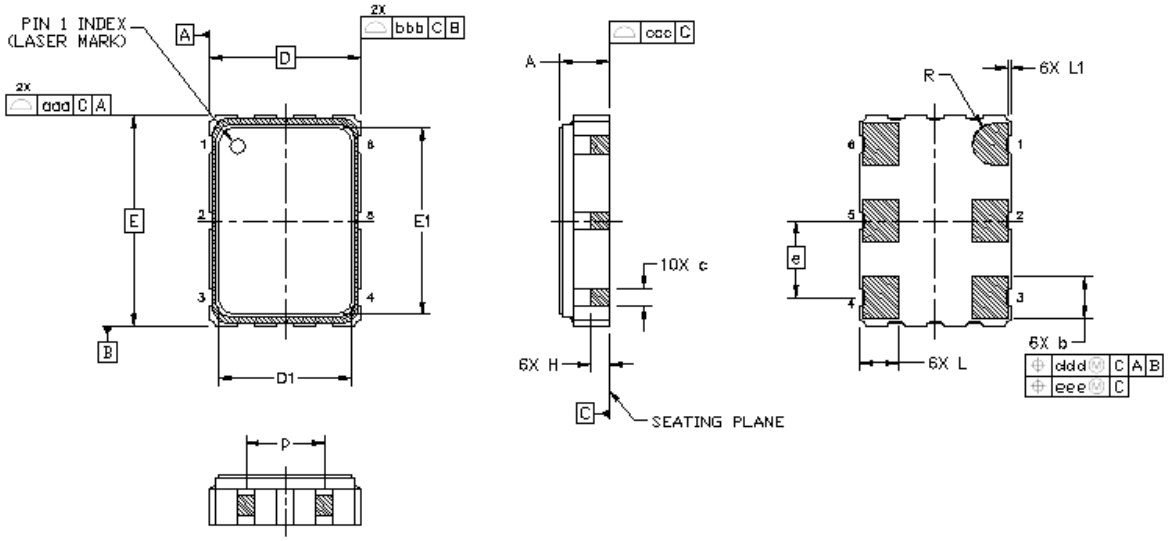


Figure 3. Si512/513 Outline Diagram

Table 15. Package Diagram Dimensions (mm)

Dimension	Min	Nom	Max
A	1.50	1.65	1.80
b	1.30	1.40	1.50
c	0.50	0.60	0.70
D		5.00 BSC.	
D1	4.30	4.40	4.50
e		2.54 BSC.	
E		7.00 BSC.	
E1	6.10	6.20	6.30
H	0.55	0.65	0.75
L	1.17	1.27	1.37
L1	0.05	0.10	0.15
p	1.80	—	2.60
R		0.70 REF.	
aaa		0.15	
bbb		0.15	
ccc		0.10	

Notes:
1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

Table 15. Package Diagram Dimensions (mm)

ddd	0.10
eee	0.05

Notes:
1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

6. PCB Land Pattern: 5 x 7 mm, 6-pin

Figure 4 illustrates the 5 x 7 mm PCB land pattern for the Si512/513. Table 16 lists the values for the dimensions shown in the illustration.

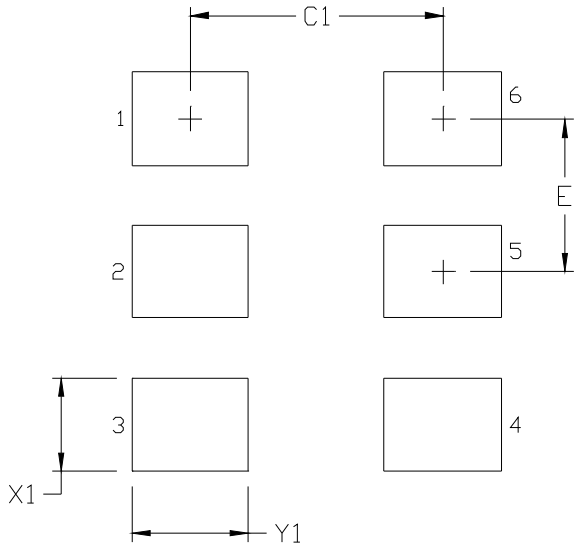


Figure 4. Si512/513 PCB Land Pattern

Table 16. PCB Land Pattern Dimensions (mm)

Dimension	(mm)
C1	4.20
E	2.54
X1	1.55
Y1	1.95

Notes:

General

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
3. This Land Pattern Design is based on the IPC-7351 guidelines.
4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

Solder Mask Design

5. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 µm minimum, all the way around the pad.

Stencil Design

6. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
7. The stencil thickness should be 0.125 mm (5 mils).
8. The ratio of stencil aperture to land pad size should be 1:1.

Card Assembly

9. A No-Clean, Type-3 solder paste is recommended.
10. The recommended card reflow profile is per the JEDEC/IPC J-STD-020C specification for Small Body Components.

7. Package Outline Diagram: 3.2 x 5.0 mm, 6-pin

Figure 5 illustrates the package details for the 3.2 x 5.0 mm Si512/513. Table 17 lists the values for the dimensions shown in the illustration.

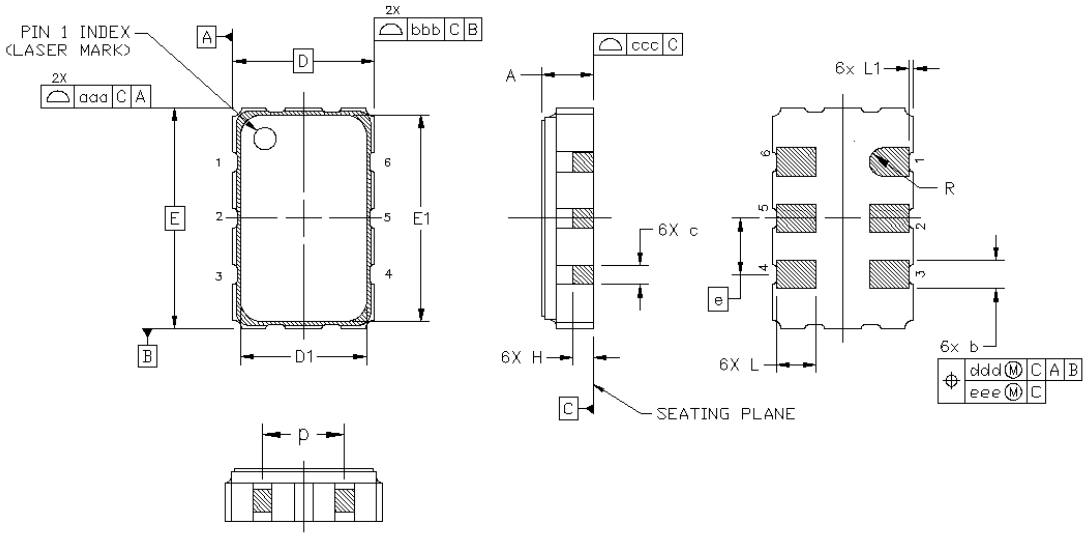


Figure 5. Si512/513 Outline Diagram

Table 17. Package Diagram Dimensions (mm)

Dimension	Min	Nom	Max
A	1.06	1.17	1.33
b	0.54	0.64	0.74
c	0.35	0.45	0.55
D		3.20 BSC	
D1	2.55	2.60	2.65
e		1.27 BSC	
E		5.00 BSC	
E1	4.35	4.40	4.45
H	0.45	0.55	0.65
L	0.80	0.90	1.00
L1	0.05	0.10	0.15
p	1.17	1.27	1.37
R		0.32 REF	
aaa		0.15	
bbb		0.15	
ccc		0.10	
ddd		0.10	

Table 17. Package Diagram Dimensions (mm) (Continued)

eee	0.05

Notes:
1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

8. PCB Land Pattern: 3.2 x 5.0 mm

Figure 6 illustrates the 3.2 x 5.0 mm PCB land pattern for the Si512/513. Table 18 lists the values for the dimensions shown in the illustration.

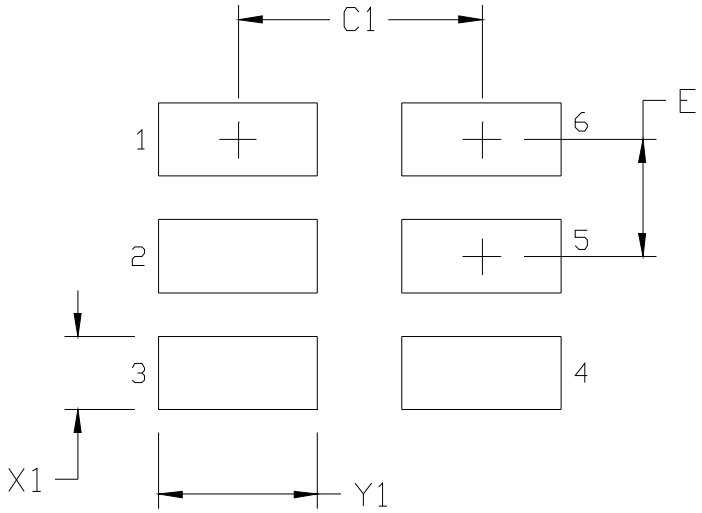


Figure 6. Si512/513 Recommended PCB Land Pattern

Table 18. PCB Land Pattern Dimensions (mm)

Dimension	(mm)
C1	2.60
E	1.27
X1	0.80
Y1	1.70

Notes:

General

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
3. This Land Pattern Design is based on the IPC-7351 guidelines.
4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

Solder Mask Design

5. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 µm minimum, all the way around the pad.

Stencil Design

6. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
7. The stencil thickness should be 0.125 mm (5 mils).
8. The ratio of stencil aperture to land pad size should be 1:1.

Card Assembly

9. A No-Clean, Type-3 solder paste is recommended.
10. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.

9. Package Outline Diagram: 2.5 x 3.2 mm, 6-pin

Figure 7 illustrates the package details for the 2.5 x 3.2 mm Si512/513. Table 19 lists the values for the dimensions shown in the illustration.

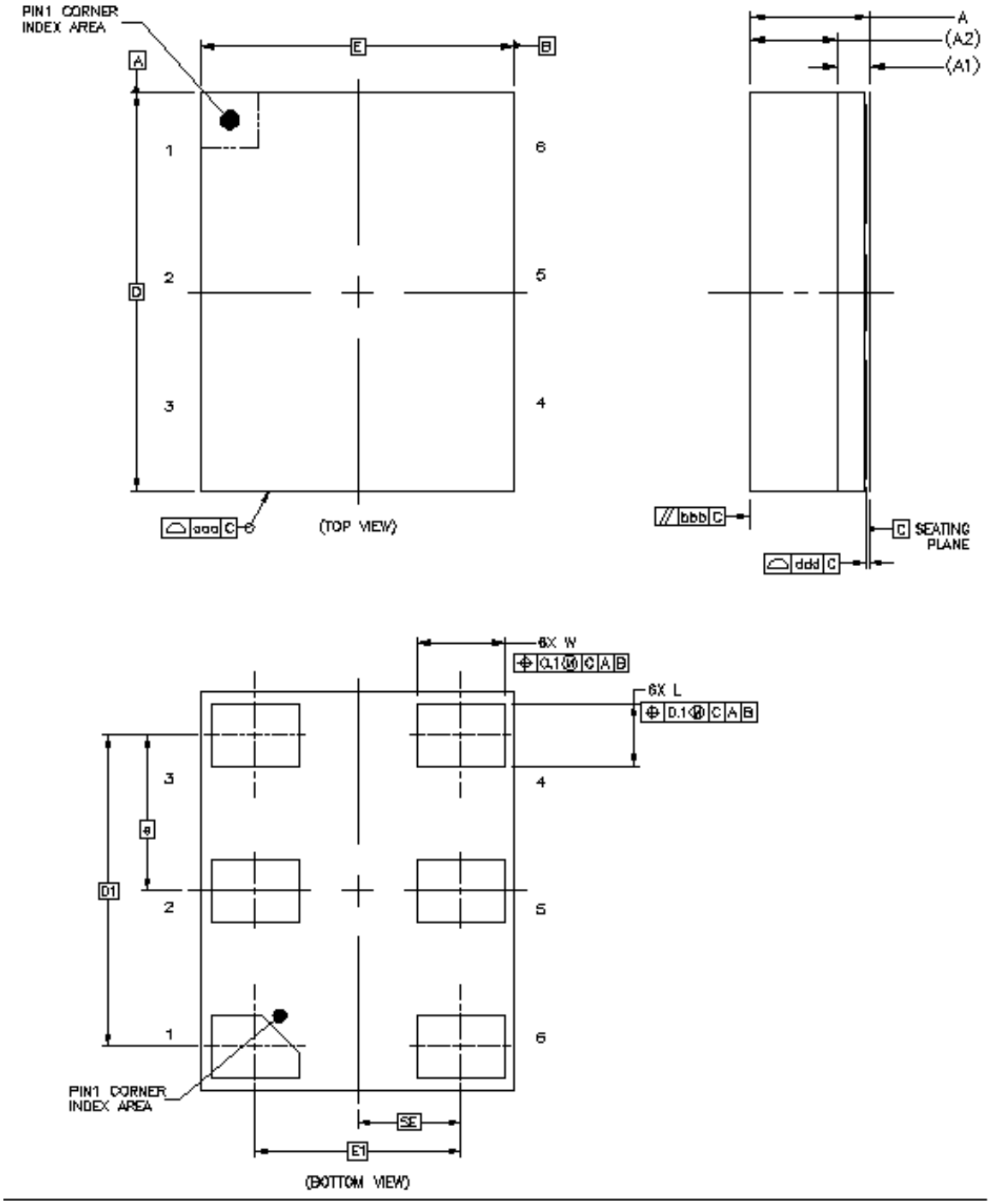


Figure 7. Si512/513 Outline Diagram

Table 19. Package Diagram Dimensions (mm)

Dimension	Min	Nom	Max
A	—	—	1.1
A1	0.26 REF		
A2	0.7 REF		
W	0.65	0.7	0.75
D	3.20 BSC		
e	1.25 BSC		
E	2.50 BSC		
M	0.30 BSC		
L	0.45	0.5	0.55
D1	2.5 BSC		
E1	1.65 BSC		
SE	0.825 BSC		
aaa	0.1		
bbb	0.2		
ddd	0.08		

Notes:
1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

10. PCB Land Pattern: 2.5 x 3.2 mm, 6-pin

Figure 8 illustrates the 2.5 x 3.2 mm PCB land pattern for the Si512/513. Table 20 lists the values for the dimensions shown in the illustration.

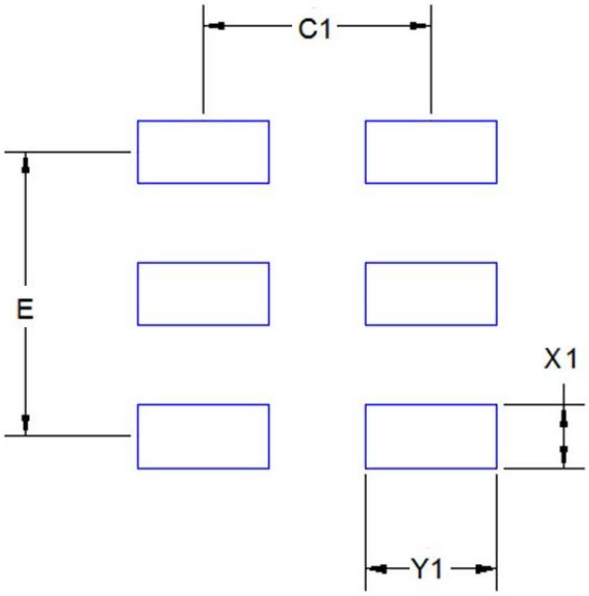


Figure 8. Si512/513 Recommended PCB Land Pattern

Table 20. PCB Land Pattern Dimensions (mm)

Dimension	(mm)
C1	1.9
E	2.50
X1	0.70
Y1	1.05

Notes:

General

3. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.
4. This Land Pattern Design is based on the IPC-7351 guidelines.

Solder Mask Design

5. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 µm minimum, all the way around the pad.

Stencil Design

6. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
7. The stencil thickness should be 0.125 mm (5 mils).
8. The ratio of stencil aperture to land pad size should be 1:1 for all perimeter pins.

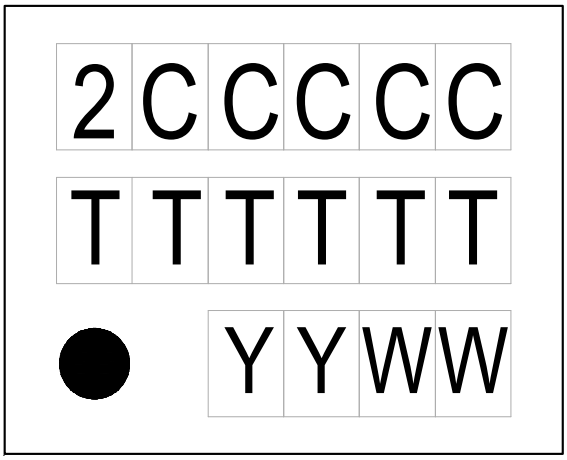
Card Assembly

9. A No-Clean, Type-3 solder paste is recommended.
10. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.

11. Top Marking

Use the part number utility located at: www.skyworksinc.com/en/application-pages/timing-lookup-customize to cross-reference the mark code to a specific device configuration.

11.1. Si512/513 Top Marking



11.2. Top Marking Explanation

Mark Method:	Laser	
Line 1 Marking:	2 = Si512 3 = Si513 CCCCC = Mark Code	2CCCCC
Line 2 Marking:	TTTTTT = Assembly Manufacturing Code	TTTTTT
Line 3 Marking:	Pin 1 indicator.	Circle with 0.5 mm diameter; left-justified
	YY = Year. WW = Work week. Characters correspond to the year and work week of package assembly.	YYWW

Revision History

Revision 1.2

June, 2018

- Changed “Trays” to “Coil Tape” in Ordering Guide.

Revision 1.1

December, 2017

- Add 2.5 x 3.2 mm package.

Revision 1.0

- Updated Table 1 on page 3.
  - Updates to supply current typical and maximum values for CMOS, LVDS, LVPECL and HCSL.
  - CMOS frequency test condition corrected to 100 MHz.
  - Updates to OE VIH minimum and VIL maximum values.
- Updated Table 2 on page 4.
  - Dual CMOS nominal frequency maximum added.
  - Total stability footnotes clarified for 10 year aging at 40 °C.
  - Disable time maximum values updated.
  - Enable time parameter added.
- Updated Table 3 on page 5.
  - CMOS output rise / fall time typical and maximum values updated.
  - LVPECL/HCSL output rise / fall time maximum value updated.
  - LVPECL output swing maximum value updated.
  - LVDS output common mode typical and maximum values updated.
  - HCSL output swing maximum value updated.
  - Duty cycle minimum and maximum values tightened to 48/52%.
- Updated Table 4 on page 6.
  - Phase jitter test condition and maximum value updated.
  - Phase noise typical values updated.
  - Additive RMS jitter due to external power supply noise typical values updated.
  - Footnote 3 updated limiting the VDD to 2.5/3.3V
- Added Tables 5, 6, 7 for LVDS, HCSL, CMOS, and Dual CMOS operations.
- Moved Absolute Maximum Ratings table.
- Added note to Figure clarifying CMOS and Dual CMOS maximum frequency.
- Updated Figure 5 outline diagram to correct pinout.
- Updated Table 17 on page 17.
- Updated “11. Top Marking” section and moved to page 23.

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